DATA SHEET

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GOLDSCOPE SD°510GOLDSCOPE SD°515GOLDSCOPE SD°520GOLDSCOPE SD°550

X-Ray Fluorescence Measuring Instruments Optimized for Fast, Cost-effective and Non-destructive Analysis of Jewellery, Coins and Precious Metals



🔲 Coating Thickness 🛄 Material Analysis 🖾 Nanoindentation 🔍 Material Testing

GOLDSCOPE SD®

Description

The X-ray fluorescence measuring instruments of the GOLDSCOPE SD[®] series are optimized for fast, cost-effective and non-destructive analysis of jewellery, coins and precious metals. Furthermore, the instruments are well suited for determining the thickness of gold coatings on sterling silver and rhodium coatings on gold alloys.

The GOLDSCOPE SD[®] series comprises four different instruments to fulfill the specific demands from the fast purchase and sale of gold up to the high-precision analysis of precious metals.

Typical fields of application are the analysis of:

- Jewellery, precious metals and dental alloys
- Yellow and white gold
- Platinum and silver
- Rhodium
- Alloys and coatings

Outstanding accuracy and long-term stability are characteristics of all X-RAY systems from **FISCHER**. The necessity of recalibration is considerably reduced, saving time and effort.

The GOLDSCOPE SD[®] 510 and SD[®] 515 instruments are equipped with a modern silicon PIN detector, which achieves high accuracy and good detection sensitivity. For even higher resolution, the GOLDSCOPE SD[®] 520 and SD 550 instruments with their Silicon Drift Detectors (SDD) are available.

The fundamental parameter method by **FISCHER** allows for the analysis without calibration.

Design

The GOLDSCOPE SD[®] instruments are designed as user-friendly bench-top instruments. Due to their compact design, the instruments are lightweight and require only little space.

The GOLDSCOPE SD[®] 510 offers the smallest footprint, because the measurement chamber door does not open upwards, but towards the front. Thus, you can place a notebook for operation onto the instrument, which saves space.

For quick and easy sample positioning, the X-ray source and detector assembly is located in the instrument's lower chamber. The measuring direction is from underneath the sample, which is supported by a transparent window.

The integrated video-microscope with zoom and crosshairs simplifies sample placement and allows for a precise measuring spot adjustment.

The entire operation and evaluation of measurements as well as the clear presentation of measurement data is performed on a PC, using the powerful and user-friendly Win FTM® software

All GOLDSCOPE SD[®] instruments fulfill DIN ISO 3497 and ASTM B 568.

Application	GOLDSCOPE SD [®] 510	GOLDSCOPE SD [®] 515	GOLDSCOPE SD [®] 520	GOLDSCOPE SD [®] 550
Recommended area of application	Retail shops	High end retail show- rooms, small assaying offices		Hallmarking centers, jewellery manufac- turing, assaying offices

General Specification				
Intended use	Energy dispersive X-ray measuring instrument (EDXRF) to analyze precious metals			
Design	GOLDSCOPE SD® 510: Bench top unit with towards the front opening hood, GOLDSCOPE SD® 515, 520, 550: Bench top unit with upwards opening hood			
Measuring direction	Bottom up			
Electrical Data				
Power supply and consumption	AC 115 or 230 V, 50/60 Hz, max. 120 W without evaluation PC			
Protection class	Ip40			
Environmental Conditions				
Operating temperature	10 °C – 45 °C / 50 °F – 113 °F			
Storage/Transport temperature	0 °C – 50 °C / 32 °F – 122 °F			
Relative humidity	≤ 95 %			
Sample Alignment				
Sample positioning	Manually			
Video microscope	High-resolution CCD colour camera for optical monitoring of the measurement locationalong the primary beam axis, Crosshairs with a calibrated scale (ruler) and spot-indicator, Adjustable LED illumination			
Zoom factor	Digital 1x, 2x, 3x, 4x			
Evaluation Unit				
Computer	Windows [®] -PC			
Software	WinFTM®- optimized for GOLDSCOPE SD®, including Gold Setup GOLDSCOPE with measuring applications for gold and jewellery			
Standards	GOLDSCOPE SD [®] 510	GOLDSCOPE SD®515 GOLDSCOPE SD®520 GOLDSCOPE SD®550		
CE approval		EN 61010, EN 61326		
X-Ray standards	DIN ISO 3497 and ASTM B 568			
Approval	Individual accep- tance inspection as a fully protected instrument accor- ding to the German regulations "Deutsche Röntgen- verordnung-RöV".	Fully protected instrument with type approval according to the German regulations "Deutsche Röntgen- verordnung - RöV".		
Sample Stage				
Design	Fixed sample support			
Max. sample weight [kg/lb]	13/29			
Usable sample placement area	305 x 490/	310 x 320/		
[mm/in]	12 x 19.3	12.2 x 12.6		
Max. sample height [mm/in]	130/5.1	90/3.5		

Dimensions	GOLDSCOPE SD [®] 510	GOLDSCOPE SD [®] 515	GOLDSCOPE SD [®] 520	GOLDSCOPE SD [®] 550	
External dimensions	405 x 588 x 426/ 403 x 1		588 x 365/16 x 23.2 x 14.4		
Width x depth x height [mm/in]	16 x 23 x 17				
Weight [kg/lb]	approx. 45/99	арргох. 45/99			
X-Ray Source					
X-ray tube	Tungsten tube, th	ermally stabilized	Micro-focus tungsten tube with beryllium window		
High voltage, three steps [kV]	30, 40, 50	30, 40, 50	30, 40, 50	10, 30, 50	
Primary filter, Material and thickness [µm/mils]	none	none	fixed Al 500/19.7	6x changeable: Ni 10/0.4 no filter Al 1000/39.4 Al 500/19.7 Al 100/3.9 Mylar [®] 100/3.9	
Aperture (Collimator)	Fixed	Fixed	Fixed,	4x changeable:	
Ø [mm/mils]	Standard 1,0/39 Option 0.6/24;	Standard 1,0/39 Option 0.6/24; 1.0/39 or 2.0/79	Standard 1.0/39 Option 0.6/24; 1.0/39 or 2.0/79	0.2/8; 0.6/24; 1.0/39; 2.0/79	
Smallest measurement spot* Ø [mm/mils]	approx. 0.7/28*	approx. 0.7/28*	approx. 0.7/28*	approx. 0.3 /12*	
	* depends on the measuring distance and on the aperture, the actual measurement spot size is shown in the video image				
X-Ray Detection					
Detector type	Silicon PIN detector	peltier-cooled	Silicon Drift Detector (SDD), peltier-cooled		
Resolution fwhm for Mn-K _a [eV]	≤]	80	≤ 160		
Element range	S (16) to U (92) Al (13) to U (92)			Al (13) to U (92)	
Measuring distance [mm/in]	0 – 25/0 – 1, Distance compensation with patented DCM method for simplified measurements at varying distances. For particular applications or for higher demands on accuracy an additional calibration might be necessary.				
Repeatability for gold,	≤ 1 ‰	≤ 1 ‰	≤0,5 ‰	≤0,5 ‰	
measurement time 60 sec	with aperture	with aperture	with aperture	with aperture	
Ordor	1.0 mm	1.0 mm	1.0 mm	1.0 mm	
Order Order number	IN605-684	IN605-685	IN605-686	IN605-687	
	Incl. Gold Setup GOLDSCOPE with factory-calibrated measuring applications for gold and jewellery				
	Special GOLDSCOPE SD® product modification and technical consultation on request				

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